

# BLF6G27-45; BLF6G27S-45

## WiMAX power LDMOS transistor

Rev. 4 — 7 March 2013

Product data sheet

## 1. Product profile

### 1.1 General description

45 W LDMOS power transistor for base station applications at frequencies from 2500 MHz to 2700 MHz.

**Table 1. Typical performance**

RF performance at  $T_{case} = 25^\circ\text{C}$  in a class-AB production test circuit.

Mode of operation	f (MHz)	$V_{DS}$ (V)	$P_{L(AV)}$ (W)	$G_p$ (dB)	$\eta_D$ (%)	ACPR <sub>885k</sub> (dBc)	ACPR <sub>1980k</sub> (dBc)
1-carrier N-CDMA <sup>[1]</sup>	2500 to 2700	28	7	18	24	-49 <sup>[2]</sup>	-64 <sup>[2]</sup>

[1] Single carrier N-CDMA with pilot, paging sync and 6 traffic channels (Walsh codes 8 - 13). PAR = 9.7 dB at 0.01 % probability on CCDF. Channel bandwidth is 1.23 MHz.

[2] Measured within 30 kHz bandwidth.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

### 1.2 Features and benefits

- Typical 1-carrier N-CDMA performance (single carrier N-CDMA with pilot, paging, sync and 6 traffic channels [Walsh codes 8 - 13]. PAR = 9.7 dB at 0.01 % probability on CCDF. Channel bandwidth is 1.23 MHz), a supply voltage of 28 V and an  $I_{Dq}$  of 350 mA:
- Qualified up to a maximum  $V_{DS}$  operation of 32 V
- Integrated ESD protection
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation
- Internally matched for ease of use
- Low gold plating thickness on leads
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

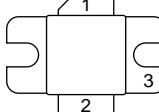
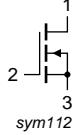
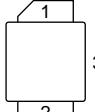
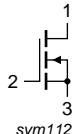


### 1.3 Applications

- RF power amplifiers for base stations and multi carrier applications in the 2500 MHz to 2700 MHz frequency range

## 2. Pinning information

**Table 2. Pinning**

Pin	Description	Simplified outline	Graphic symbol
<b>BLF6G27-45 (SOT608A)</b>			
1	drain		
2	gate		
3	source	[1]	 
<b>BLF6G27S-45 (SOT608B)</b>			
1	drain		
2	gate		
3	source	[1]	 

[1] Connected to flange.

## 3. Ordering information

**Table 3. Ordering information**

Type number	Package			Version
	Name	Description		
BLF6G27-45	-	flanged ceramic package; 2 mounting holes; 2 leads		SOT608A
BLF6G27S-45	-	ceramic earless flanged package; 2 leads		SOT608B

## 4. Limiting values

**Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	65	V
$V_{GS}$	gate-source voltage		-0.5	+13	V
$I_D$	drain current		-	20	A
$T_{stg}$	storage temperature		-65	+150	°C
$T_j$	junction temperature		-	200	°C

## 5. Thermal characteristics

**Table 5. Thermal characteristics**

Symbol	Parameter	Conditions	Type	Typ	Unit
$R_{th(j-case)}$	thermal resistance from junction to case	$T_{case} = 80 \text{ }^{\circ}\text{C}$ ; $P_L = 34 \text{ W (CW)}$	BLF6G27-45	1.7	K/W
			BLF6G27S-45	1.7	K/W

## 6. Characteristics

**Table 6. Characteristics**

$T_j = 25 \text{ }^{\circ}\text{C}$  per section; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}$ ; $I_D = 0.5 \text{ mA}$	65	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10 \text{ V}$ ; $I_D = 60 \text{ mA}$	1.4	1.9	2.4	V
$I_{DSS}$	drain leakage current	$V_{GS} = 0 \text{ V}$ ; $V_{DS} = 28 \text{ V}$	-	-	1.4	$\mu\text{A}$
$I_{DSX}$	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 \text{ V}$ ; $V_{DS} = 10 \text{ V}$	8.8	10.4	-	A
$I_{GSS}$	gate leakage current	$V_{GS} = 11 \text{ V}$ ; $V_{DS} = 0 \text{ V}$	-	-	140	nA
$g_{fs}$	forward transconductance	$V_{DS} = 10 \text{ V}$ ; $I_D = 2.5 \text{ A}$	-	4.3	-	S
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V}$ ; $I_D = 2.1 \text{ A}$	-	0.24	0.385	$\Omega$
$C_{rs}$	feedback capacitance	$V_{GS} = 0 \text{ V}$ ; $V_{DS} = 28 \text{ V}$ ; $f = 1 \text{ MHz}$	-	1.1	-	pF

## 7. Application information

**Table 7. Application information**

Mode of operation: Single carrier N-CDMA with pilot, paging, sync and 6 traffic channels (Walsh codes 8 - 13). PAR 9.7 dB at 0.01 % probability on CCDF; channel bandwidth = 1.23 MHz;  $f = 2700 \text{ MHz}$ ; RF performance at  $V_{DS} = 28 \text{ V}$ ;  $I_{Dq} = 350 \text{ mA}$ ;  $T_{case} = 25 \text{ }^{\circ}\text{C}$ ; unless otherwise specified; in a class-AB production circuit.

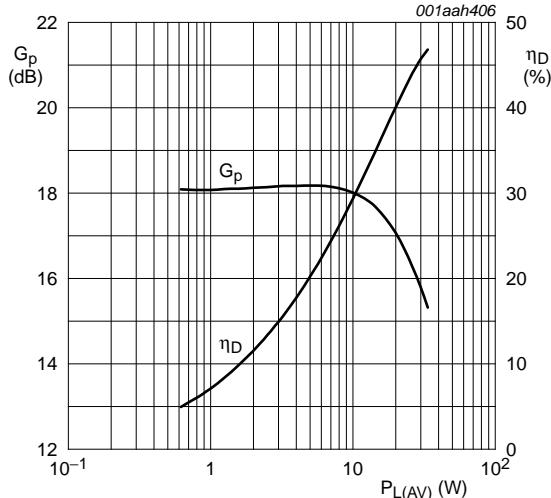
Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
$P_{L(AV)}$	average output power		-	7	-	W	
$G_p$	power gain	$P_{L(AV)} = 7 \text{ W}$	16.5	18	-	dB	
$RL_{in}$	input return loss	$P_{L(AV)} = 7 \text{ W}$	-	-10	-5	dB	
$\eta_D$	drain efficiency	$P_{L(AV)} = 7 \text{ W}$	22	24	-	%	
$ACPR_{885k}$	adjacent channel power ratio (885 kHz)	$P_{L(AV)} = 7 \text{ W}$	[1]	-	-49	-46	dBc
$ACPR_{1980k}$	adjacent channel power ratio (1980 kHz)	$P_{L(AV)} = 7 \text{ W}$	[1]	-	-64	-61	dBc

[1] Measured within 30 kHz bandwidth.

### 7.1 Ruggedness in class-AB operation

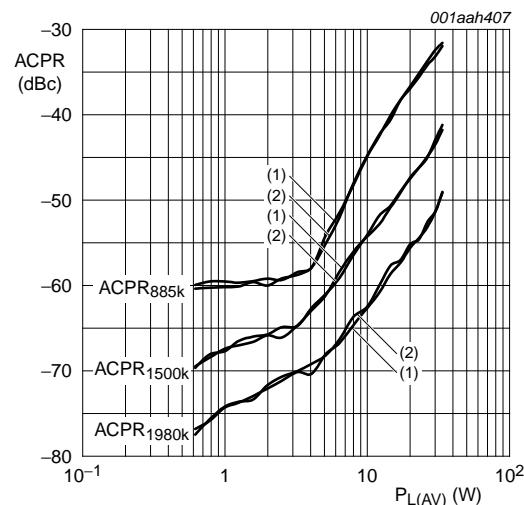
The BLF6G27-45 and BLF6G27S-45 are capable of withstanding a load mismatch corresponding to  $VSWR = 10 : 1$  through all phases under the following conditions:  $V_{DS} = 28 \text{ V}$ ;  $I_{Dq} = 350 \text{ mA}$ ;  $P_L = 45 \text{ W (CW)}$ ;  $f = 2600 \text{ MHz}$ .

## 7.2 Single carrier N-CDMA performance



$V_{DS} = 28$  V;  $I_{Dq} = 350$  mA;  $f = 2600$  MHz; single carrier N-CDMA; PAR = 9.7 dB at 0.01 % probability; channel bandwidth = 1.23 MHz; instantaneous bandwidth = 30 kHz.

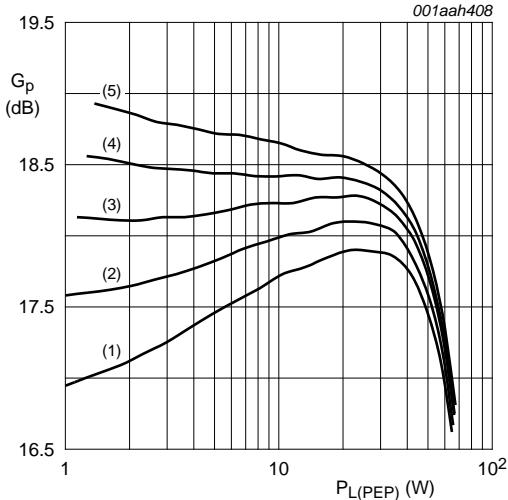
**Fig 1. Power gain and drain efficiency as functions of average load power; typical values**



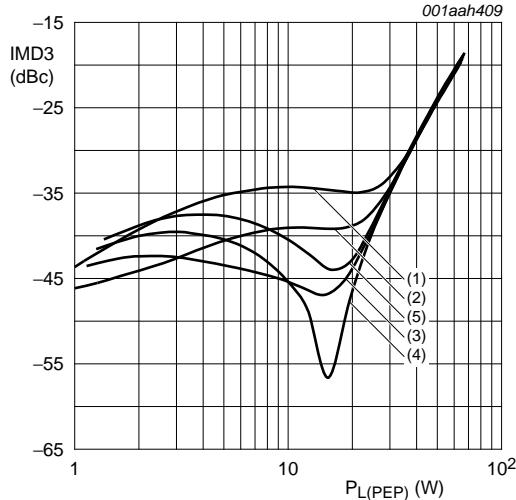
$V_{DS} = 28$  V;  $I_{Dq} = 350$  mA;  $f = 2600$  MHz; single carrier N-CDMA; PAR = 9.7 dB at 0.01 % probability; channel bandwidth = 1.23 MHz; instantaneous bandwidth = 30 kHz.

**Fig 2. Adjacent channel power ratio as function of average load power; typical values**

### 7.3 Two-tone



$V_{DS} = 28$  V;  $f_1 = 2598.75$  MHz;  $f_2 = 2601.25$  MHz;  
2.5 MHz tone spacing.

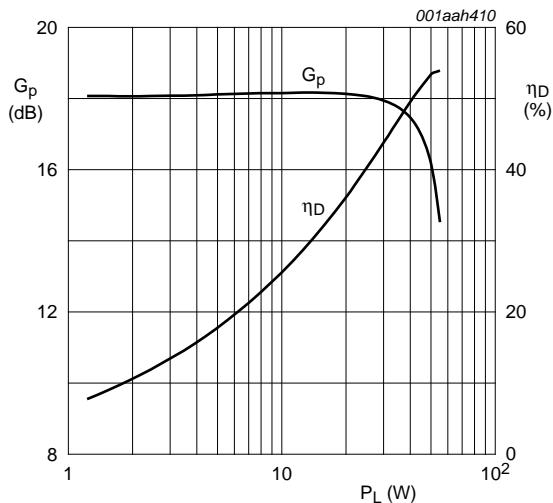


$V_{DS} = 28$  V;  $f_1 = 2598.75$  MHz;  $f_2 = 2601.25$  MHz;  
2.5 MHz tone spacing.

**Fig 3.** Power gain as function of peak envelope load power; typical values

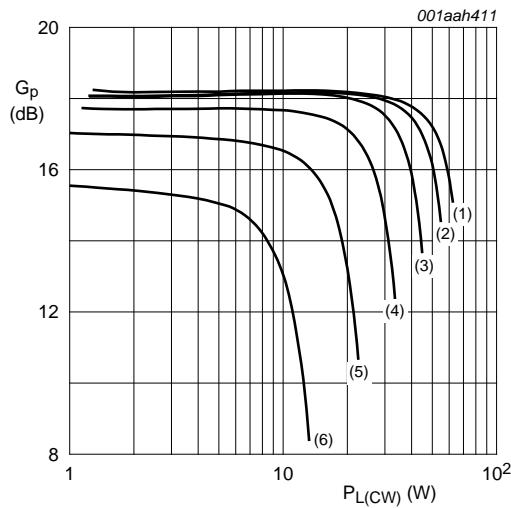
**Fig 4.** Third order intermodulation distortion as function of peak envelope load power; typical values

## 7.4 Continuous wave



$I_{Dq} = 350 \text{ mA}$ ;  $f = 2600 \text{ MHz}$ ;  $T_{\text{case}} = 25^\circ\text{C}$ ;  $V_{DS} = 28 \text{ V}$ .

**Fig 5. Power gain and drain efficiency as functions of CW load power; typical values**

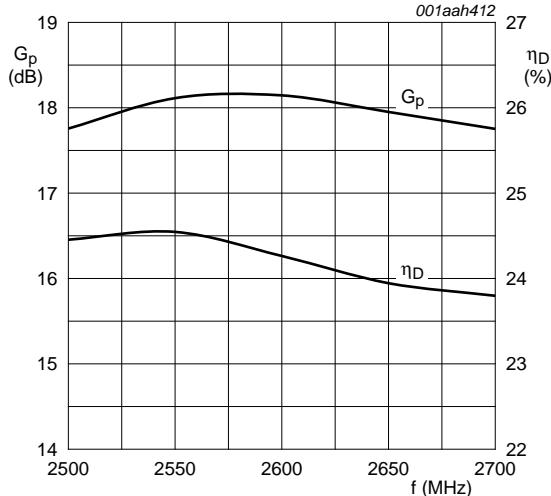


$I_{Dq} = 350 \text{ mA}$ ;  $f = 2600 \text{ MHz}$ ;  $T_{\text{case}} = 25^\circ\text{C}$ .

- (1)  $V_{DS} = 32 \text{ V}$
- (2)  $V_{DS} = 28 \text{ V}$
- (3)  $V_{DS} = 24 \text{ V}$
- (4)  $V_{DS} = 20 \text{ V}$
- (5)  $V_{DS} = 16 \text{ V}$
- (6)  $V_{DS} = 12 \text{ V}$

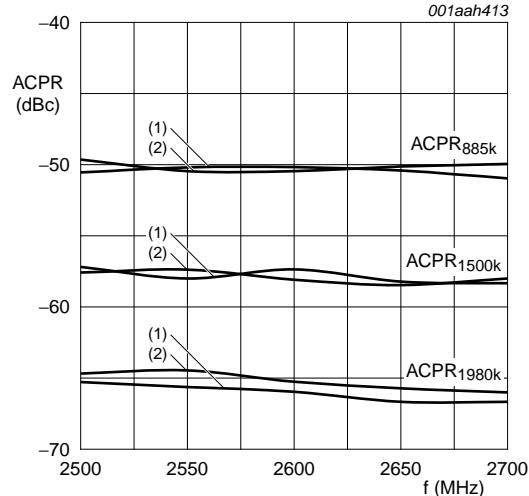
**Fig 6. Power gain as function of CW load power; typical values**

## 7.5 Single carrier N-CDMA broadband performance at 7 W average



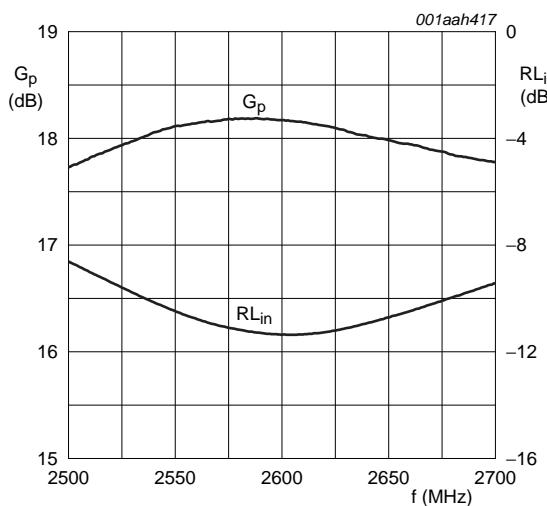
$V_{DS} = 28$  V;  $I_{Dq} = 350$  mA; single carrier N-CDMA;  
PAR = 9.7 dB at 0.01 % probability;  
instantaneous bandwidth = 30 kHz.

**Fig 7. Power gain and drain efficiency as functions of frequency; typical values**



$V_{DS} = 28$  V;  $I_{Dq} = 350$  mA; single carrier N-CDMA;  
PAR = 9.7 dB at 0.01 % probability;  
instantaneous bandwidth = 30 kHz.

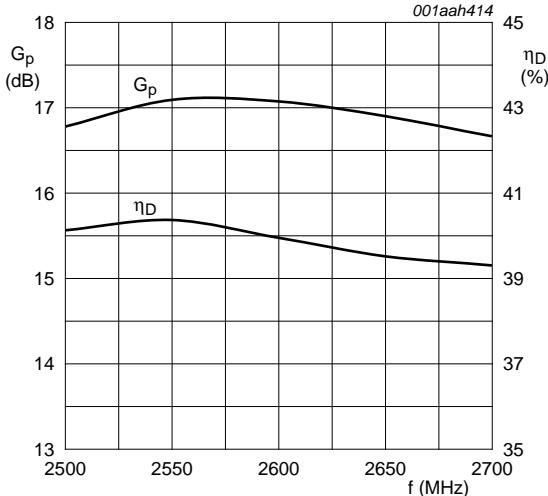
**Fig 8. Adjacent channel power ratio as function of frequency; typical values**



$V_{DS} = 28$  V;  $I_{Dq} = 350$  mA; single carrier N-CDMA; PAR = 9.7 dB at 0.01 % probability; instantaneous bandwidth = 30 kHz.

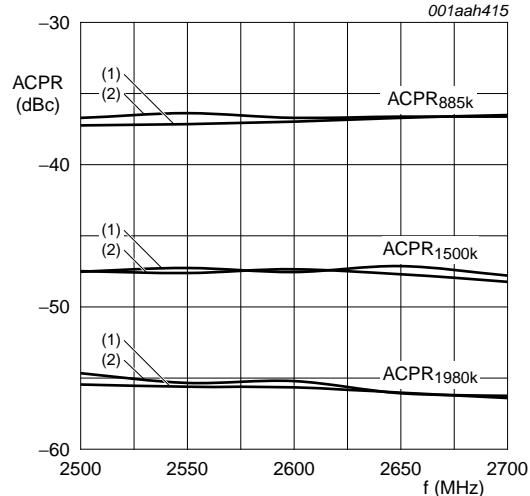
**Fig 9. Power gain and input return loss as functions of frequency**

## 7.6 Single carrier N-CDMA broadband performance at 20 W average



$V_{DS} = 28$  V;  $I_{Dq} = 350$  mA; single carrier N-CDMA;  
PAR = 9.7 dB at 0.01 % probability;  
instantaneous bandwidth = 30 kHz.

**Fig 10. Power gain and drain efficiency as functions of frequency; typical values**

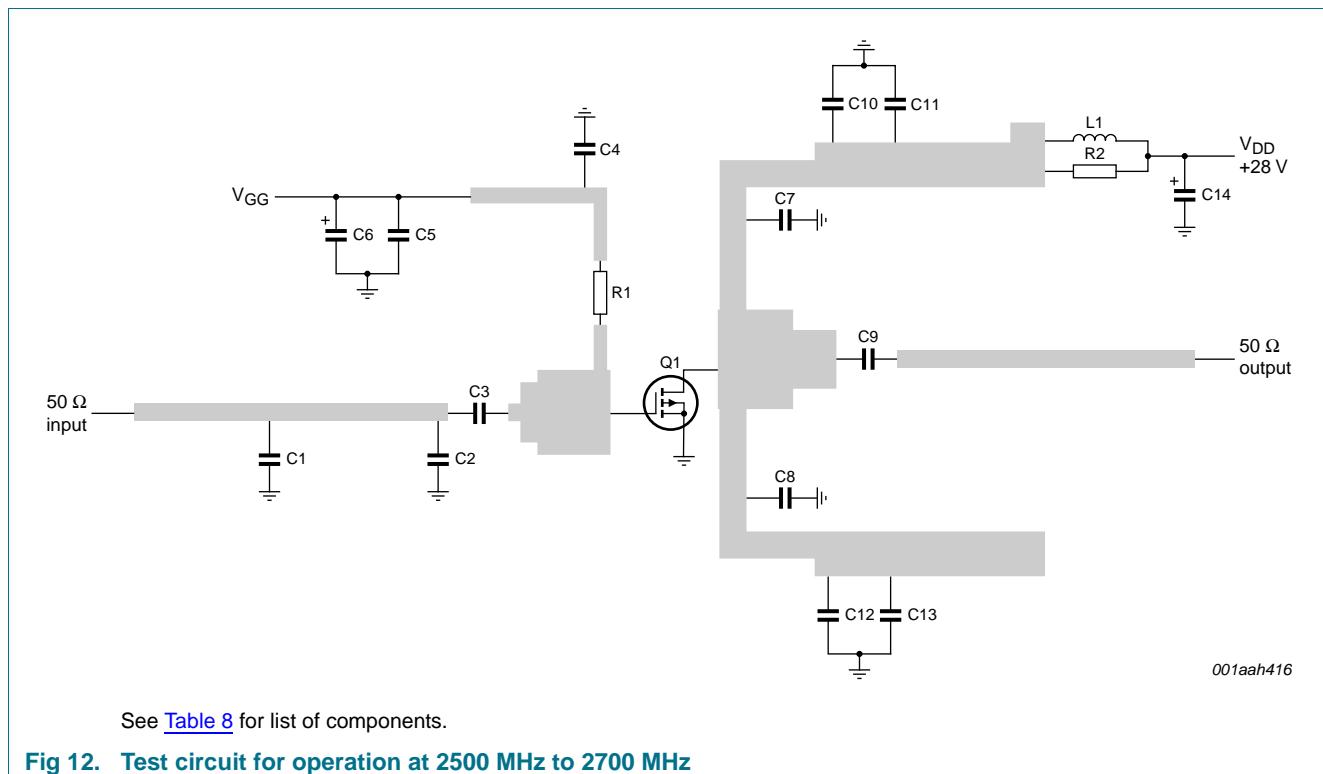


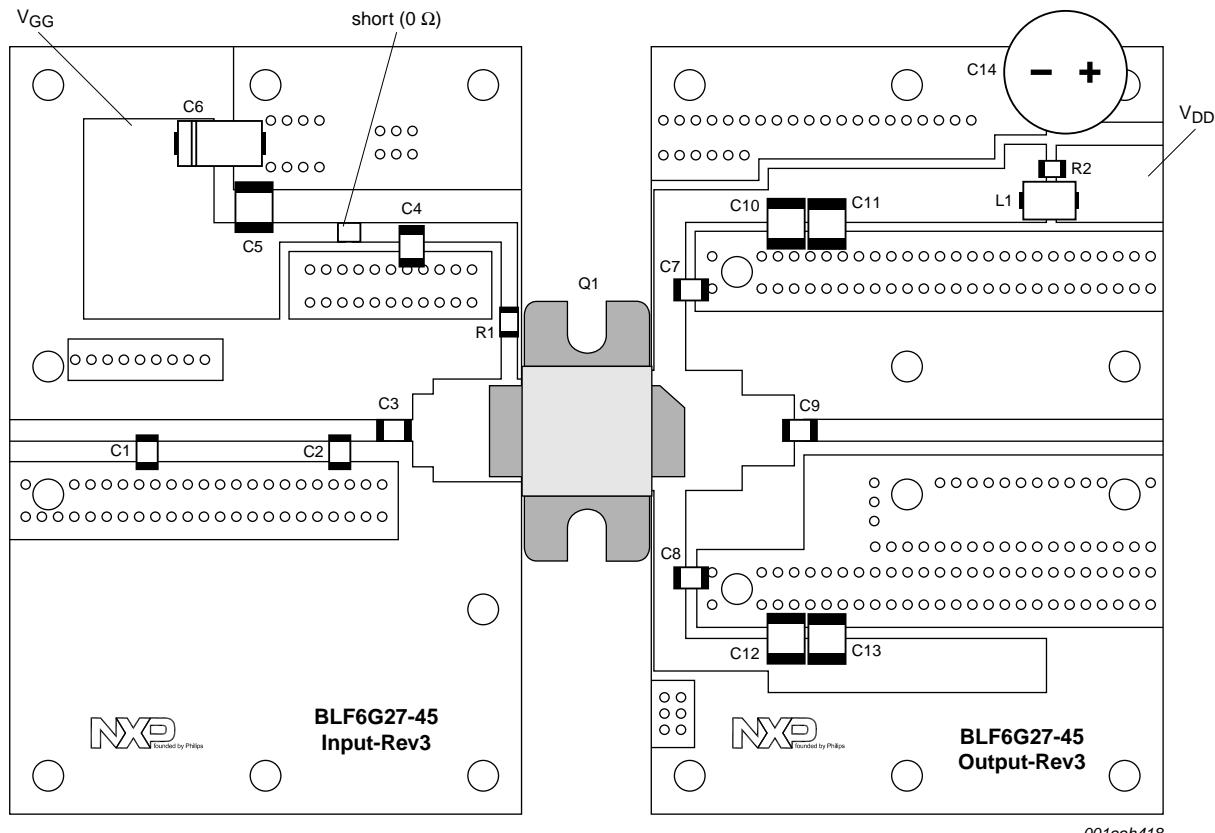
$V_{DS} = 28$  V;  $I_{Dq} = 350$  mA; single carrier N-CDMA;  
PAR = 9.7 dB at 0.01 % probability;  
instantaneous bandwidth = 30 kHz.

- (1) Low frequency component
- (2) High frequency component

**Fig 11. Adjacent channel power ratio as function of frequency; typical values**

## 8. Test information





Striplines are on a double copper-clad Taconic RF35 Printed-Circuit Board (PCB) with  $\epsilon_r = 3.5$  and thickness = 0.76 mm.  
See [Table 8](#) for list of components.

**Fig 13. Component layout for 2500 MHz to 2700 MHz test circuit**

**Table 8. List of components**

For test circuit, see [Figure 12](#) and [Figure 13](#).

Component	Description	Value	Remarks
C1	multilayer ceramic chip capacitor	0.3 pF	[1]
C2	multilayer ceramic chip capacitor	0.5 pF	[1]
C3, C4, C7, C8	multilayer ceramic chip capacitor	11 pF	[1]
C5, C10, C11, C12, C13	multilayer ceramic chip capacitor	4.7 $\mu$ F	C4532X7R1H475M
C6	tantalum capacitor	10 $\mu$ F; 35 V	Kemet (Farnell)
C9	multilayer ceramic chip capacitor	8.2 pF	
C14	electrolytic capacitor	470 $\mu$ F; 63 V	
L1	ferrite SMD bead	-	Ferroxcube BDS 3/3/4.6-4S2 or equivalent
R1	resistor	22 $\Omega$	package 0603
R2	resistor	12 $\Omega$	package 1206
Q1	BLF6G27-45 or BLF6G27S-45	-	

[1] American Technical Ceramics type 100B or capacitor of same quality.

**Table 9. Measured test circuit impedances**

f (GHz)	Z <sub>i</sub> (Ω)	Z <sub>o</sub> (Ω)
2.50	11.1 – j11.0	18.4 – j9.1
2.55	10.6 – j10.8	16.9 – j9.2
2.60	10.1 – j10.5	15.6 – j9.2
2.65	9.6 – j10.2	14.4 – j9.1
2.70	9.1 – j9.8	13.3 – j8.9

## 9. Package outline

Flanged ceramic package; 2 mounting holes; 2 leads

SOT608A

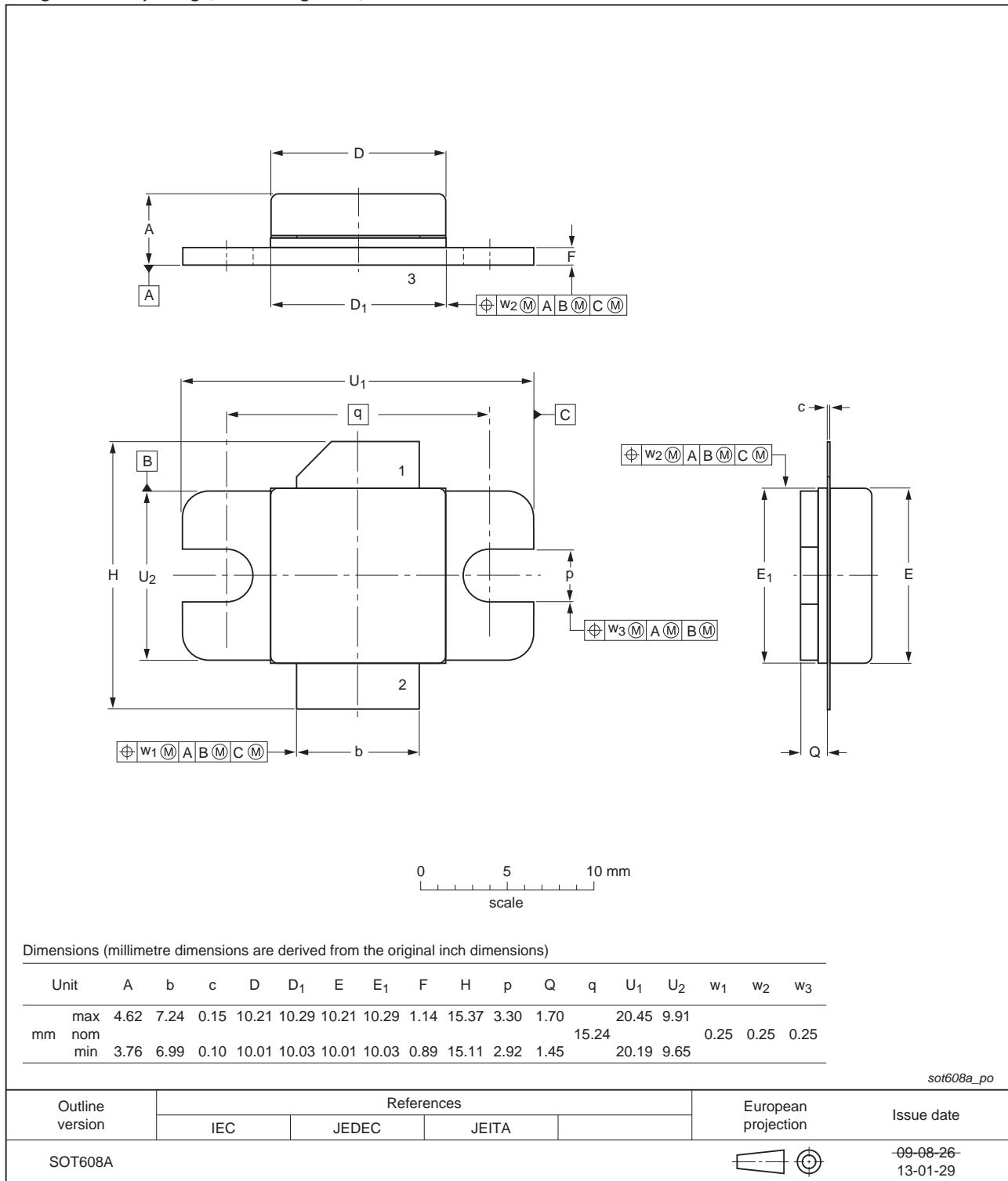


Fig 14. Package outline SOT608A

Ceramic earless flanged package; 2 leads

SOT608B

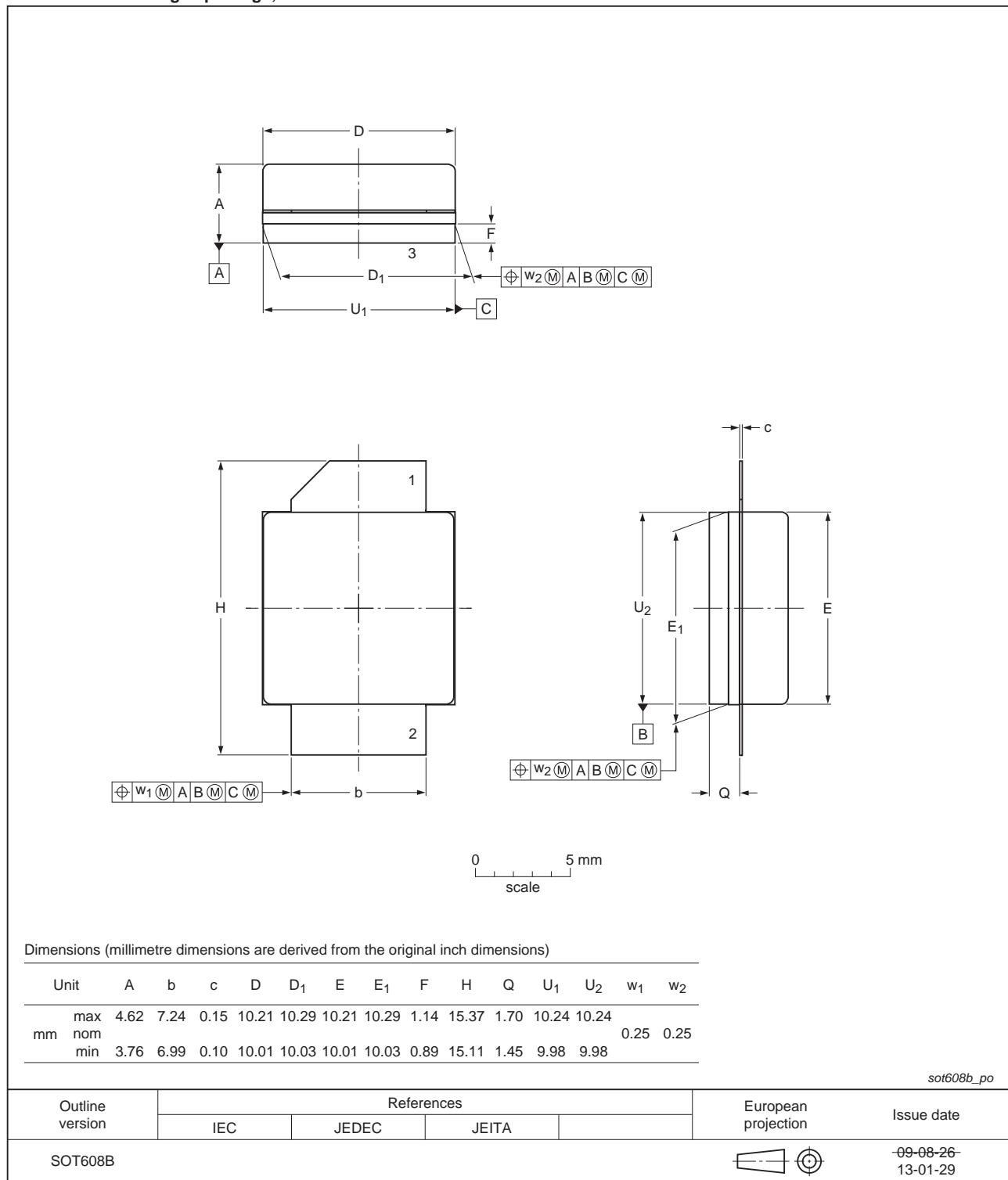


Fig 15. Package outline SOT608B

## 10. Abbreviations

**Table 10. Abbreviations**

Acronym	Description
CCDF	Complementary Cumulative Distribution Function
CW	Continuous Wave
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
N-CDMA	Narrowband Code Division Multiple Access
PAR	Peak-to-Average power Ratio
RF	Radio Frequency
SMD	Surface Mounted Device
VSWR	Voltage Standing-Wave Ratio
WiMAX	Worldwide Interoperability for Microwave Access

## 11. Revision history

**Table 11. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF6G27-45_BLF6G27S-45 v.4	20130307	Product data sheet	-	BLF6G27-45_BLF6G27S-45_3
Modifications:		• Update of Package Outline drawing.		
BLF6G27-45_BLF6G27S-45_3	20081215	Product data sheet	-	BLF6G27-45_BLF6G27S-45_2
BLF6G27-45_BLF6G27S-45_2	20080207	Preliminary data sheet		BLF6G27-45_BLF6G27S-45_1
BLF6G27-45_BLF6G27S-45_1	20080129	Preliminary data sheet		

## 12. Legal information

### 12.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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## 14. Contents

<b>1</b>	<b>Product profile</b>	<b>1</b>
1.1	General description	1
1.2	Features and benefits	1
1.3	Applications	2
<b>2</b>	<b>Pinning information</b>	<b>2</b>
<b>3</b>	<b>Ordering information</b>	<b>2</b>
<b>4</b>	<b>Limiting values</b>	<b>2</b>
<b>5</b>	<b>Thermal characteristics</b>	<b>3</b>
<b>6</b>	<b>Characteristics</b>	<b>3</b>
<b>7</b>	<b>Application information</b>	<b>3</b>
7.1	Ruggedness in class-AB operation	3
7.2	Single carrier N-CDMA performance	4
7.3	Two-tone	5
7.4	Continuous wave	6
7.5	Single carrier N-CDMA broadband performance at 7 W average	7
7.6	Single carrier N-CDMA broadband performance at 20 W average	8
<b>8</b>	<b>Test information</b>	<b>9</b>
<b>9</b>	<b>Package outline</b>	<b>12</b>
<b>10</b>	<b>Abbreviations</b>	<b>14</b>
<b>11</b>	<b>Revision history</b>	<b>14</b>
<b>12</b>	<b>Legal information</b>	<b>15</b>
12.1	Data sheet status	15
12.2	Definitions	15
12.3	Disclaimers	15
12.4	Trademarks	16
<b>13</b>	<b>Contact information</b>	<b>16</b>
<b>14</b>	<b>Contents</b>	<b>17</b>

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